

GDS-3000 Series

500/350/250/150MHz Digital Storage Oscilloscope

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DS-3000GD6BH

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FEATURES

- 500/350/250/150MHz Bandwidth, 2/4 Input Channel
- 5GSa/s Real-time Sampling Rate and 100GSa/s Equivalent Time Sampling Rate
- 25k Points Memory for Each Input Channel
- VPO (Visual Persistence Oscilloscope) Technology to Display Less-Frequently-Occurred Signals
- 8" 800 x 600 High Resolution TFT LCD Display
- Unique Split Screen System with Independent Setting and Display for Each Input Channel
- Three Built-in Input Impedance Selections: $50\Omega/75\Omega/1M\Omega$
- Optional Power Analysis Software for Power Source Measurement and Analysis
- Optional Serial bus Analysis Software for Trigger & Decode of I² C, SPI and UART Interfaces





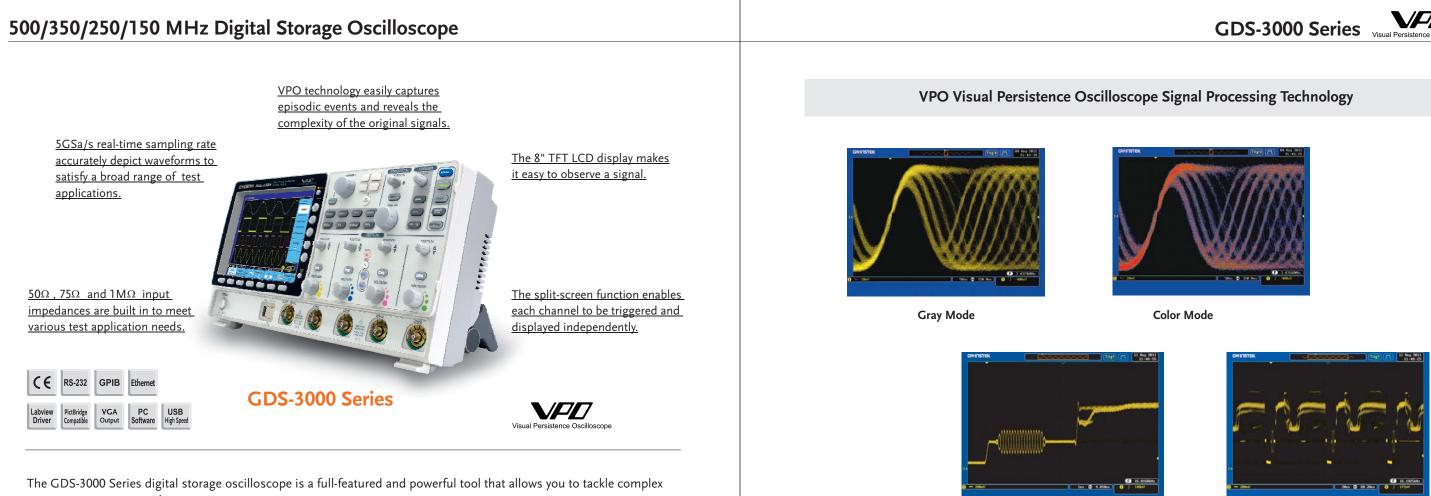


Visual Persistence Oscilloscope









A Hi-tech DSO Platform

meeting requirements of most power measurement standards.

measurement issues with ease.

The GDS-3000 Series, carrying a maximum bandwidth of 500MHz, is equipped with a real-time sampling rate up to 5GSa/s and an equivalent-time sampling rate of 100GSa/s. The large 8-inch SVGA LCD screen, combined with the advanced digital signal processing technology VPO, provides meticulous detail and clarity for the displayed waveforms. The GDS-3000 Series gives you confidence not to miss any part of the test signal in the product verification and debugging stages and allows you to speed up your task without hesitation.

5GSa/s Sampling & VPO Technology

The GDS-3000 Series adopts VPO (Visual Persistence Oscilloscope) signal processing technology to enhance the performance of multi-gray-scale waveform display. The FPGA parallel processing, instead of conventional microprocessor architecture, is applied in GDS-3000 Series design to significantly increase the data processing speed and therefore increase the waveform update rate. This technology allows the GDS-3000 Series to display waveforms with various gray scales based on the occurrence frequencies, a fashion analogous to the analog oscilloscope display. As the visual persistence oscilloscope contains 3-dimension waveform data, including amplitude, time and intensity, for each waveform spot, it provides more useful signal information than a normal digital storage oscilloscope can do. The highspeed data processing of VPO technology enables the signal analysis of rapid events such as video, jitter, glitch and runt.

The GDS-3000 Series features a maximum real-time sampling rate of 5GSa/s, which is superior to most of the equivalent oscilloscopes available in the market today. (4GSa/s maximum sampling rate for GDS-3502 & GDS-3504 and 2.5GSa/s maximum sampling rate for GDS-3152 & GDS-3252). The series is also equipped with an equivalent- time sampling rate of 100 GSa/s, providing an economic solution for the waveform acquisition and reconstruction of very high-speed repetitive signals. The fast-acquisition capability along with VPO signal processing technology, make GDS-3000 a very handy tool for observing occasionally-occurred signals such as transient and inrush events. With powerful technology, GDS-3000 Series gives you full confidence in every acquisition of complex waveform that adheres to high-speed circuit design of modern products.





The GDS-3000 Series equipped with VPO signal processing technology and 5GSa/s high-speed real-time sampling rate, allows you to view the video signal clearly.

The GDS-3000 Series is a new platform of 4-input channels, 500MHz bandwidth, 5GSa/s sampling rate, and VPO waveform display. The split screen feature has been designed to meet the requirements of multi-window & multi-signal tests in the research and the manufacturing fields. The optional power analysis software and the optional serial bus analysis software are available to facilitate the engineer's tasks in testing and manufacturing of the associated products. Three new differential probes, GDP-025, GDP-050 & GDP-100, and five new current probes, GCP-005, GCP-020, GCP-100, GCP-530 & GCP-1030, are coming along with the GDS-3000 Series to provide total solutions for a wide variety of applications in the industry, service and education market sectors. The GDS-3000 Series, a high-tech platform carrying thoughtful features, brings very high customer value to both general purpose market and professional market.

Serial Bus Analysis Software and Power Quality Analysis Software

With widespread applications of embedded system adopting serial bus communication standards, resolving unexpected issues, such as propagation delay and bus contention, is often a challenge to design and testing engineers. The GDS-3000 Series provides (optional) design and testing engineers with powerful tools for the communication analysis and debugging of most the popular serial interface projects including I² C ,SPI and UART.

To fulfill the increasing power measurement demands, as a green energy trend, GDS-3000 provides an embedded power analysis software (optional), which includes measurements of Power Quality, Harmonics, Ripple and Inrush Current,

500/350/250/150 MHz Digital Storage Oscilloscope

1. 8"TFT LCD Panel

The bright 8" TFT LCD display makes multiple signal observation easy.

2. 5GSa/s Real-time Sampling Rate for Fast Waveform Capture

The high speed sampling technology used for data acquisition truthfully reconstructs complex signals.

3. VISUAL Persistence Oscilloscope Signal Processing Technology

VPO signal processing technology displays waveforms in 3 dimensions - amplitude, time and intensity.

4. Compact Design

With a depth of only 5 inches, the compact size of the product doesn't occupy valuable work space.

5. Split Window Function (Split Screen)

The GDS-3000 Series supports up to four independently operated and triggered windows at a time so that you can simultaneously monitor up to 4 signals carrying different characteristics.

6. Auto-Range Function

The Auto Range function automatically adjusts the time base and/or the vertical scale of displayed waveform when the frequency and/or the amplitude of input signal changed.

7. High Speed USB 2.0 Port

USB Host port for easy access of stored data.

8. Three Input Impedance Selections

The three built-in input impedances (75 Ω , 50 Ω ,1M Ω) can be selected to meet the requirements of various applications.

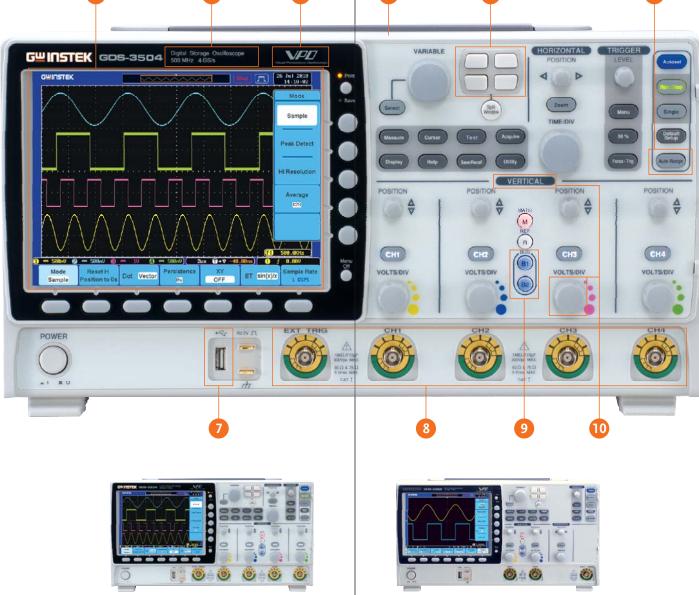
9. Serial Bus Triggering and Decode (Optional)

2 dedicated keys used for setting recall in the serial bus analysis applications supporting UART, I 2 C and SPI serial bus.

10. Independent Channel Design

The independent zone of vertical operations for each channel substantially increases the measurement efficiency.





4 Channel Model

2 Channel Model

			SELECT	ION GUI	DE			
Model	GDS-3504	GDS-3502	GDS-3354	GDS-3352	GDS-3254	GDS-3252	GDS-3154	GDS-3152
Bandwidth	500MHz	500MHz	350MHz	350MHz	250MHz	250MHz	150MHz	150MHz
Channels	4	2	4	2	4	2	4	2
Record Length	25k/Channel							
Real-Time Sampling	4 GSa/s	4 GSa/s	5 GSa/s	5 GSa/s	5 GSa/s	2.5 GSa/s	5 GSa/s	2.5 GSa/s
Equivalent- Time Sampling	100GSa/s							

* 2 Channels on Max Sampling Rate : 2GSa/s (GDS-3504/3502); 2.5GSa/s (GDS-3354/3352/3254/3154); 1.25GSa/s (GDS-3252/3152) * 3, 4 Channels on Max Sampling Rate : 2GSa/s (GDS-3504); 1.25GSa/s (GDS-3354/3254/3154) GDS-3000 Series Visual I





11. USB Ports as Standard

USB Host/Device interfaces for easy access of stored data and direct print-out through a PictBridge compatible printer.

12. LAN Port as Standard

LAN interfaces for remote control and monitoring.

13. Line Output

3.5mm stereo sound output for Go/NoGo buzzer.

14. RS-232 Interface

15. SVGA Video Output

SVGA video output port allows the transfer of DSO screen image to an external projector or monitor for remote monitoring or big screen observation.

16. Go/NoGo BNC

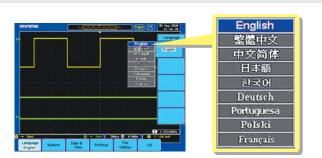
The open collector output signal allows external instrument to be controlled by the test result.

17. Trigger Output Port

A 5V TTL Level trigger signal is available for the synchronization with other devices.

18. Self-Calibration Signal Output

Self-Calibration signal output for input channel vertical gain calibration.

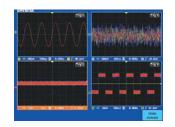


Multi-Language Support

The GDS-3000 Series interface supports multiple languages to provide the upmost convenience for cross-country team cooperation and multinational engineering efforts.

500/350/250/150 MHz Digital Storage Oscilloscope

UNIQUE SPLIT SCREEN FUNCTION



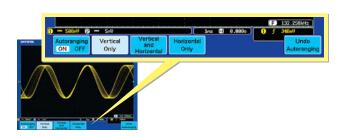
The unique split screen feature of GDS-3000 Series allows each input channel to be operated independently with respective setting and waveform display. The time base, the vertical sensitivity, and the trigger selections can be done by each channel separately, and the waveform of each input signal can be shown on the individual part of the screen. This nearly four-DSO-inone feature* is very useful for the applications that need to simultaneously see the details of multiple waveforms with very different characteristics. The 8-inch high resolution 800x600 LCD display makes the split screen a pleasant observation environment to view the details of complex signals.



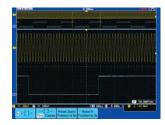
COMPLETE SET of TRIGGER FUNCTIONS

Besides Edge trigger, the GDS-3000 Series also offers various trigger functions, including Video, Pulse Width, Runt, Rise Time & Fall Time (specific time length), Alternate, Delay by Time, Delay by Event, and Hold-Off. The high sampling rate, the VPO signal processing & display, and the flexible trigger function all together make the GDS-3000 Series a powerful tool for waveform capture and display of various types of signals.

AUTO RANGE for both TIME BASE and VERTICAL SCALE



DUAL DISPLAY WINDOW ZOOM



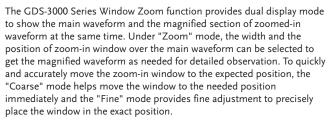
The Auto Range function automatically adjusts the time base and/or the vertical scale of displayed waveform when the frequency and/or the amplitude of input signal changed. This function gives user the convenience to have DSO always display waveform in a proper fashion on the screen tracking the frequency and amplitude changes of the input signal. It is especially useful when the user needs to alternately probe and test multiple circuit points containing signals with different frequencies and amplitudes.

28 AUTOMATIC MEASUREMENTS



The GDS-3000 Series supports simultaneous measurement of up to 28 waveform measurement items grouped into three main waveform parameters: amplitude, time and delay measurements. The display modes include an individual mode and a Display All mode. The former can display any 8 of the automatic measurements while the later can display all the automatic measurements for a channel.

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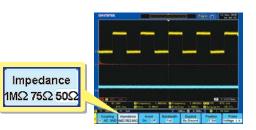


FFT TEST FUNCTION

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117				

To observe fundamental and harmonic frequency components of a signal, the FFT function on a digital storage oscilloscope is often used. Typically the traditional unit of the FFT is decibel (dB). However, when using dB it is sometimes difficult to identify the fundamental frequency of a signal from a noisy spectrum. With FFTrms function, the GDS-3000 Series can clearly display the fundamental frequency of an acquired waveform. The FFT function of GDS-3000 supports Rectangular, Hamming, Hanning, and Black-harris windows.

THREE INPUT IMPEDANCE SELECTIONS



Three input impedance, $1M\Omega$, 75Ω , and 50Ω are available for user's selection. The flexibility of impedance selections, including $1M\Omega$ to get minimum loading effect, 75Ω to accommodate Video transmission applications and 50Ω to fit RF communication applications, extends the GDS-3000 Series utilization range.

EXTENDABLE APPLICATION SOFTWARE



The GDS-3000 Series allows future installation of additional application software at the user site. This provides an open environment for optional software upgrade and additional feature built-in in whenever the GDS-3000 Series user has the need. The flexibility of software installation platform keeps the DSO being in use always up-to-date.

FREE REMOTE CONTROL SOFTWARE



Using a USB port coupled with FreeWave remote monitoring software is the easiest and most convenient way to capture data from the GDS-3000 Series. With FreeWave, a screenshot can be saved as an image file (.bmp/.jpg)and waveform data (.csv).

Not only can FreeWave monitor and record waveforms over a long period of time, but previously recorded waveforms can also be observed. Instrument settings can even be configured without the need to learn incomprehensible command line syntax. With the simple user interface and robust features, FreeWave allows you to get the most out of the GDS-3000 with little effort.

GDS-3000 Series



X-Y MODE

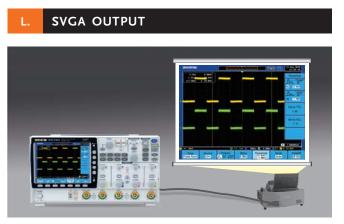


The X-Y mode of GDS-3000 defines CH1 and CH3 as the horizontal axis and CH2 and CH4 as the vertical axis, allowing the display of 2 sets of X-Y pattern simultaneously. The measurement items include Rectangular, Polar, Product and Ratio that fits most of the popular X-Y applications. The X-Y pattern and the time domain waveforms can be shown on the screen simultaneously. Two cursors on the time domain waveforms allow the identification of cursor-associated locations on the X-Y pattern display.

WAVEFORM FILE PREVIEW



The GDS-3000 provides an optimized operation interface for viewing screen captures. Generally, the oscilloscope may store large amounts of waveform data after a long period of time. To help prevent engineers from selecting the wrong file from a large number of stored waveform files, the screen capture preview function can be used to preview the waveform file without opening files so that operation of the oscilloscope is more efficient and convenient.



A SVGA video output port in the rear panel of GDS-3000 Series allows the screen-image transfer from DSO to an external projector or a monitor for remote monitoring or big screen observation. This direct image transfer feature greatly increase the efficiency of presentation in the meeting, teaching in the class, remote monitoring of hazardous events from a secured zone, and fast and easy monitoring in the production line.

VARIOUS INTERFACES SUPPORT



Two high-speed USB 2.0 Host ports located in both front panel and rear panel are used for easy access of stored data. In the rear panel, a USB Device port is available for remote control and hardcopy print-out through a PictBridge compatible printer. RS-232 and LAN interfaces are provided as standard for system communication & ATE applications.

A SVGA video output port allows the transfer of DSO screen image to an external projector or monitor for remote monitoring or big screen observation. A GPIB to USB adaptor is available as an option for interface conversion though the USB Device port in the front panel.

SERIAL BUS ANALYSIS SOFTWARE SUPPORTING 1²C, SPI and UART (OPTIONAL)





I²C Serial Bus Analysis Software

SPI Serial Bus Analysis Software

POWER ANALYSIS SOFTWARE FOR POWER SUPPLY MEASUREMENTS (OPTIONAL)

With serial bus technology being widely used in embedded applications, the proper triggering and analysis of flowing data, control signal and associated pulse waveforms in serial bus communication has been a difficult job and challenge to design engineers. The Serial Bus Analysis software of GDS-3000 Series carries complete analysis tools for triggering and decoding of commonly used serial bus interfaces, including I² C, SPI

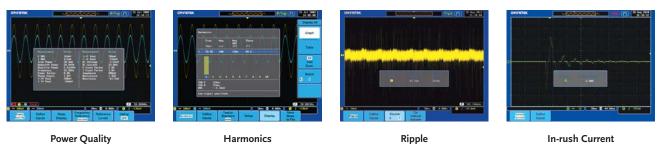


UART Serial Bus Analysis Software

The GDS-3000 Series provides two dedicated keys in the front panel for tow sets of setting recall

and UART. Without spending time to study serial bus regulation details, the user only needs to set the trigger condition on GDS-3000 to get the data slots of interest.

* Only four-channel models support SPI function.



The Power Analysis software contains four measurement functions, including Power Quality, Harmonics, Ripple and Inrush Current. The Power Quality analysis function allows the measurements of Voltage, Current, Frequency, Power and other quality related parameters for power source efficiency improvement. The Harmonics analysis function performs evaluation of power waveform distortion and gives harmonic



In-rush Current

test data for power source design and quality check. This function is complied with IEC 61000-3-2 standard. The Ripple measurement function, acquiring the ripple and noise overriding the DC waveform, is used to evaluate the DC power source quality. The Inrush Current measurement function is used to measure the power-on surge current, which may cause the damage of the device circuit.



GCP-005/100/020

GCP-530/1030 & GCP-206P/425P

In addition to the standard passive probes, the optional current or differential probes can be used to perform additional tests or power analysis. The differential probes come in three bandwidths: 25MHz, 50MHz and 100MHz. The current probes come in a broad variety of bandwidth and current ranges (ranging from 50MHz/30A, 100MHz/30A, 10kHz/200A and 100kHz/100A), to cover any number of power supply testing applications.

* The GCP-530/1030 must be used in conjunction with the GCP-206P/425P current probe power supply.

CURRENT PROBE GCP-005 GCP-100 GCP-020 GCP-530 40Hz~1kHz DC~100kHz 40Hz~40kHz DC~50MHz Probe Bandwidth DC Rise Time 3 5 7ns or less Maximum Continuous .05~10A(100mV/A) 0.1~24A(100mV/A) 30A 5A 30Arms ~100A(10mV/A) 0.5~240A(10mV/A Input Range Maximum Peak 60A(100mV/A 50A 100A 50Arms 50A Current Value 600À(10mV/A 00mV/A;10mV 10mV/A;100mV/A 0.1V/A 0.1 Output Voltage Rate 10mV/A 2%±50mV 00mA~20A pea ±0.5%rdg <3%±5mV ±1.0%rdg±1mV Amplitude Accuracy ±1 00ma~20A peak) 3.5%±5mV 0.5~10A peak) 3%±5mV 0~40A peak) 1.5%±5mV 50mA~10A pea (0~30Arms/DC, (0 (50/60Hz) ≤4%±500µV 45~66Hz);±2.0%rdg 45-+1.0%rdg (0.5A~40A peak) (30Arms~50A peak (30A ±0.2mV 15%(40~100A peak) /DC, 45~66Hz) /D (40~1kHz) 00A~240A pea 2.5mArms or less 2.5r Noise ---±12V± 0.5V ±1 Rate Supply Voltage _ _ 5.6VA 5.3\ _ Maximum Rated Power Maximum Rated Voltage 600V, CAT III 600V, CAT III 600V, CAT III 300V, CAT I 300

	HIGH-VOLTAGE	DIFFERENTIAL PRO
	GDP-025	GDP-050
Probe Bandwidth	DC ~ 25MHz(attenuationx50, x200) ; DC ~ 15MHz(attenuationx20)	DC ~ 50MHz(attenuationx2 DC ~ 25MHz(attenuationx1
Attenuation	x20 , x50 , x200	x100 , x200 , x500 , x1000
Accuracy	±2%	±2%
Voltage Input Range (DC+AC peak to peak)	≤ 140Vp-p for x 20 , ≤ 350Vp-p for x 50 , ≤ 1400Vp-p for x 200	≤ 700Vp-p for x 100 ≤ 1400Vp-p for x 200 ≤ 3500Vp-p for x 500 ≤ 7000Vp-p for x 1000
Permitted Max Input Voltage	Maximum differential voltage: Max voltage between input terminal and ground: 600Vrms	Maximum differential voltag Max voltage between input t ground: 6500Vrms
Input Impedance	Differential:4M Ω /1.2pF ; Between terminals and ground: 2M Ω /2.3pF	Differential:54M Ω /1.2pF ; Between terminals and grou
Output	≤7.0V	≤7.0V
Output impedance	50Ω	50Ω
Rise Time	14ns (x50, x200 attenuation) ; 23.4ns (x20 attenuation)	7ns (x200, x500, x1000 atten 14ns (x100 attenuation)
Rejection Rate on Common Mode (CMRR)	60Hz>80dB , 100Hz>60dB, 1MHz>50dB	60Hz>80dB , 100Hz>60dB, 1MHz>50dB
Power Supply	External DC adapter	External DC adapter
Consumption	Maximum 200mA(1.8Watt)	Maximum 200mA(1.8Watt)

GDS-3000 Series



Current Probe and Differential Probe Selections





GDP-025

GDP-050/100

* The GCP-100 requires a standard 9V battery; The GCP-005 and GCP-020 do not require batteries or a power supply source.

	CURRENT	PROBE POWER	SUPPLY
GCP-1030		GCP -206P	GCP-425P
C~100MHz	Compatible Current	GCP-530	GCP-530
5ns or less	Probe	GCP-1030	GCP-1030
Arms	Number of Power Supply Connectors	2	4
Arms	Output Voltage	±12V± 0.5V	±12V± 0.5V
1V/A	Rated Output Current	±600mA	±2.5A
.0%rdg±1mV ~30Arms/DC, ~66Hz);±2.0%rdg	Rated Supply Voltage (50/60Hz)	110V/120V,220V/240V AC±10%	100V~240V AC±10%
0Arms~50A peak DC, 45~66Hz)	Maximum Rated Power	20VA	170VA
5mArms or less 12V± 0.5V 3VA	Dimensions & Weight	73(W)x110(H)x 186(D)mm; Approx.1.1kg	80(W)x119(H)x 200(D) mm ; Approx.1.1kg
00V, CAT I	Accessories	Power cord, fuse	Power cord, fuse

FERENTIAL PROBE GDP-050 GDP-100 ~ 50MHz(attenuationx200, x500, x1000) DC ~ 100MHz (attenuationx200, x500 , x1000) ~ 25MHz(attenuationx100) DC ~ 50MHz (attenuationx100) 00, x200, x500, x1000 x100, x200, x500, x1000 ±2% 00Vp-p for x 100 \leq 700Vp-p for x 100 400Vp-p for x 200 < 1400Vp-p for x 200 500Vp-p for x 500 ≤ 3500Vp-p for x 500 000Vp-p for x 1000 ≤ 7000Vp-p for x 1000 ximum differential voltage: Maximum differential voltage: Max voltage between input terminal and voltage between input terminal and und: 6500Vrms ground: 6500Vrms ferential:54M Ω /1.2pF Differential: 54MΩ/1.2pF ; ween terminals and ground:27M Ω /2.3pF Between terminals and ground: $27M\Omega/2.3pF$.0V \leq 7.0V **50**Ω 3.5ns (x200, x500, x1000 attenuation); (x200, x500, x1000 attenuation); is (x100 attenuation) 7ns (x100 attenuation) Hz>80dB, 100Hz>60dB, 60Hz>80dB, 100Hz>60dB,

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1MHz>50dB

External DC adapter

Maximum 200mA(1.8Watt)

500/350/250/150 MHz Digital Storage Oscilloscope

SPECIFICATIONS								
	GDS-3152	GDS-3154	GDS-3252	GDS-3254	GDS-3352	GDS-3354	GDS-3502	GDS-3504
VERTICAL			1	1				
Channels	2Ch+EXT	4Ch+EXT	2Ch+EXT	4Ch+EXT	2Ch+EXT	4Ch+EXT	2Ch+EXT	4Ch+EXT
Bandwidth	DC~150M		DC~250N	1Hz(-3dB)	DC~350N	IHz(-3dB)	DC~500M	Hz(-3dB)
Rise Time Bandwidth Limit	2.3 20M	ins 1 Ll –		1ns 00MHz	1 r 20M/100N		700	
			,		,	1/200101112	20101/100101/2	200/350MHz
Vertical Resolution	8 bits	$1 \text{ of the } 75 \Omega$ in	put impedance i	s limited to 150	iviHz only			
Vertical Resolution	2mV~5V/div							
(1ΜΩ) Vertical Resolution	2mV~1V/div							
(50/75 Ω)								
Input Coupling Input Impedance	AC, DC, GND 1MΩ// 15pF							
DC Gain Accuracy	±3% full scale	2						
Polarity Maximum Input	Normal , Inve 300Vrms, CAT							
Voltage(1ΜΩ)								
Maximum Input /oltage(50/75Ω)	5 Vrms , CAT	1						
Offset Position Range	2mV/div ~ 10	0mV/div : ±0.5	V ; 200mV/div	~ 5V/div : ±25V	,			
Waveform Signal Process				eforms, Differe FFT vertical sc				
FIOCESS				ckman-Harris.				indow to
TRIGGER								
Source	2CH model: C	CH1, CH2, Line	e, EXT ; 4CH m	odel: CH1 , CH	2 , CH3 , CH4	Line , EXT		
Trigger Mode				ind slower), No		· ··		
Trigger Type				all, Alternate, C s),Time-Delay				
Trigger Holdoff Range	10ns ~ 10s			-,,	(, ,	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,		
Coupling Sensitivity		j., HF rej., No	,	150MHz Appro	x 15 div or 15 n	a)/· 150MHz. 31		2 div or 20mV
Sensitivity		MHz Approx. 2			x. 1.501v 0r 151	10, 13010112~3.	Joining Approx.	
EXT TRIGGER								
Range	±15V							
Sensitivity		Iz Approx. 100		Hz ~ 350MHz A	oprox 150mV	350MHz~500N	1Hz Approx 20	0mV
Input Impedance	1MΩ±3%, ~		,		,			
HORIZONTAL								
Range Bro trigger	1ns/div ~ 100 10 div maxim	s/div (1-2-5 ind	crements; GDS	-3502/3504 1-2	.5-5 increments)ROLL : 100ms	/div ~ 100s/div	/
Pre-trigger Post-trigger	1,000 div max	(depend on t						
Accuracy	±20 ppm ove	er any <u>></u> 1 ms ti	ime interval					
VVNOFF								
X-Y MODE			iel 2: Channel 4	4				
X-Axis Input/Y-Axis Input		nannel 3/Chanr		ŧ				
X-Axis Input/Y-Axis Input Phase Shift	±3°at 100kH:	'		+				
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION	±3°at 100kH:	z			5650/6	5650/6	ACSolo	ACSolo
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate	±3°at 100kH: 2.5GSa/s	z 5GSa/s	2.5GSa/s	* 5GSa/s	5GSa/s	5GSa/s	4GSa/s	4GSa/s
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate ET Sample Rate Memory Depth	±3°at 100kH: 2.5GSa/s	z	2.5GSa/s		5GSa/s	5GSa/s	4GSa/s	4GSa/s
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate ET Sample Rate Memory Depth	±3°at 100kH 2.5GSa/s 100GSa/s ma 25k points Normal, Avera	z 5GSa/s iximum for all r age, Peak deteo	2.5GSa/s nodels ct, High resolut	5GSa/s ion, Single	5GSa/s	5GSa/s	4GSa/s	4GSa/s
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate ET Sample Rate Memory Depth Acquisition Mode	±3°at 100kHz 2.5GSa/s 100GSa/s ma 25k points Normal, Avera Average: 2 ~ 2	z 5GSa/s iximum for all r age, Peak deteo	2.5GSa/s models	5GSa/s ion, Single	5GSa/s	5GSa/s	4GSa/s	4GSa/s
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate ET Sample Rate Memory Depth Acquisition Mode	±3°at 100kHz 2.5GSa/s 100GSa/s ma 25k points Normal, Avera Average: 2 ~ 2 JREMENT	z 5GSa/s iximum for all r age, Peak deteo 256 waveforms	2.5GSa/s nodels ct, High resolut ; Peak detect: 2	5GSa/s ion, Single	5GSa/s	5GSa/s	4GSa/s	4GSa/s
X-Y MODE X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate ET Sample Rate Memory Depth Acquisition Mode CURSORS AND MEASU Cursors Automatic	±3°at 100kH: 2.5GSa/s 100GSa/s ma 25k points Normal, Avera Average: 2 ~ 2 JREMENT Amplitude, Ti 28 sets: Vpp ,	z 5GSa/s iximum for all r age, Peak detee 256 waveforms me, Gating ava Vamp , Vavg ,	2.5GSa/s nodels ct, High resolut ; Peak detect: 2 ailable Vrms , Vhi , Vlo	5GSa/s ion, Single 2ns o , Vmax , Vmin	, Rise Preshoo	t/ Overshoot , I	Fall Preshoot/C	vershoot,
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate ET Sample Rate Memory Depth Acquisition Mode CURSORS AND MEASU Cursors	±3°at 100kH: 2.5GSa/s 100GSa/s ma 25k points Normal, Aver: Average: 2 ~ 2 JREMENT Amplitude, Ti 28 sets: Vpp , Freq , Period ,	z 5GSa/s iximum for all r age, Peak detee 256 waveforms me, Gating avz Vamp , Vavg , Rise time , Fai	2.5GSa/s nodels ct, High resolut ; Peak detect: 2 ailable Vrms , Vhi , Vlo	5GSa/s tion, Single 2ns 9 , Vmax , Vmin e width , Negati	, Rise Preshoo	t/ Overshoot , I	Fall Preshoot/C	vershoot,
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate ET Sample Rate Memory Depth Acquisition Mode CURSORS AND MEASU Cursors Automatic Measurement Cursors Measurement	±3°at 100kH: 2.5GSa/s 100GSa/s ma 25k points Normal, Avera Average: 2 ~ 2 JREMENT Amplitude, Ti 28 sets: Vpp , Freq , Period , measurement Voltage differe	z 5GSa/s ximum for all r age, Peak detec 256 waveforms me, Gating ava Vamp , Vavg , , Rise time , Fa ts (FRR, FRF, F ence between c	2.5GSa/s nodels ct, High resolut ; Peak detect: 2 ailable Vrms , Vhi , Vlo II time , Positiv FR, FFF, LRR, L cursors (△V) T	5GSa/s tion, Single 2ns > , Vmax , Vmin e width , Negati RF, LFR, LFF) ime difference l	, Rise Preshoo ve width , Duty petween cursor	t/ Overshoot , I cycle, Phase, a	Fall Preshoot/C	vershoot,
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate ET Sample Rate Memory Depth Acquisition Mode CURSORS AND MEASU Cursors Automatic Measurement Cursors Measurement Auto Counter	±3°at 100kH: 2.5GSa/s 100GSa/s ma 25k points Normal, Avera Average: 2 ~ 2 JREMENT Amplitude, Ti 28 sets: Vpp , Freq , Period , measurement Voltage differe 6 digits, range	z 5GSa/s ximum for all r age, Peak detec 256 waveforms me, Gating ava Vamp , Vavg , , Rise time , Fa ts (FRR, FRF, F ence between c	2.5GSa/s nodels ct, High resolut ; Peak detect: 2 ailable Vrms , Vhi , Vlo II time , Positiv FR, FFF, LRR, L cursors (△V) T	5GSa/s ion, Single 2ns o , Vmax , Vmin e width , Negati RF, LFR, LFF)	, Rise Preshoo ve width , Duty petween cursor	t/ Overshoot , I cycle, Phase, a	Fall Preshoot/C	vershoot,
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate ET Sample Rate Memory Depth Acquisition Mode CURSORS AND MEASL Cursors Automatic Measurement Cursors Measurement Auto Counter POWER MEASUREMEN	±3°at 100kH: 2.5GSa/s 100GSa/s ma 25k points Normal, Avera Average: 2 ~ 2 JREMENT Amplitude, Ti 28 sets: Vpp , Freq , Period , measurement Voltage differe 6 digits, range	z 5GSa/s iximum for all r age, Peak detec 256 waveforms me, Gating av Vamp , Vavg , , Rise time , Fai ts (FRR, FRF, F ence between c e from 2Hz min	2.5GSa/s nodels ct, High resolut ; Peak detect: 2 ailable Vrms , Vhi , Vlc I time , Positivi FR, FFF, LRR, L cursors (△V) T nimum to the r	5GSa/s ion, Single 2ns 9 , Vmax , Vmin e width , Negati RF, LFR, LFF) ime difference l ated bandwidth	, Rise Preshoo ve width , Duty between cursor	t/ Overshoot , I cycle, Phase, a s (△T)	Fall Preshoot/C nd eight differe	vershoot, nt delay
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate ET Sample Rate Memory Depth Acquisition Mode CURSORS AND MEASU CURSORS AND MEASU Cursors Automatic Measurement Cursors Measurement Auto Counter POWER MEASUREMEN Power Quality	±3°at 100kH: 2.5GSa/s 100GSa/s ma 25k points Normal, Avera Average: 2 ~ 2 JREMENT Amplitude, Ti 28 sets: Vpp , Freq , Period , measurement Voltage differe 6 digits, range	z 5GSa/s iximum for all r age, Peak detec 256 waveforms me, Gating av Vamp , Vavg , , Rise time , Fai ts (FRR, FRF, F ence between c e from 2Hz min	2.5GSa/s nodels ct, High resolut ; Peak detect: 2 ailable Vrms , Vhi , Vlc I time , Positivi FR, FFF, LRR, L cursors (△V) T nimum to the r	5GSa/s tion, Single 2ns > , Vmax , Vmin e width , Negati RF, LFR, LFF) ime difference l	, Rise Preshoo ve width , Duty between cursor	t/ Overshoot , I cycle, Phase, a s (△T)	Fall Preshoot/C nd eight differe	vershoot, nt delay
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate ET Sample Rate Memory Depth Acquisition Mode CURSORS AND MEASU Cursors Automatic Measurement Cursors Measurement Auto Counter POWER MEASUREMEN Power Quality Measurements Harmonics	±3°at 100kH: 2.5CSa/s 100GSa/s ma 25k points Normal, Aver. Average: 2 ~ 2 JREMENT Amplitude, Ti 28 sets: Vpp , Freq , Period , measurement Voltage differe 6 digits, range ITS(OPTION) VRMS, VCrest Freq, Mag, Mi	z 5GSa/s iximum for all r age, Peak detec 256 waveforms "me, Gating ava Vamp , Vavg , , Rise time , Fa ts (FRR, FRF, F ence between c e from 2Hz min factor, Frequence ag rms, Phase,	2.5GSa/s nodels ct, High resolut ; Peak detect: 2 ailable Vrms , Vhi , Vlc I time , Positivi FR, FFF, LRR, L cursors (△V) T nimum to the r	5GSa/s tion, Single 2ns , Vmax , Vmin e width , Negati RF, LFR, LFF) ime difference l ated bandwidth factor, True pow	, Rise Preshoo ve width , Duty between cursor	t/ Overshoot , I cycle, Phase, a s (△T)	Fall Preshoot/C nd eight differe	vershoot, nt delay
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate ET Sample Rate Memory Depth Acquisition Mode CURSORS AND MEASU Cursors Automatic Measurement Cursors Measurement Auto Counter POWER MEASUREMEN Power Quality Measurements Harmonics Ripple Measurements	±3°at 100kH: 2.5CSa/s 100CSa/s ma 25k points Normal, Aver: Average: 2 ~ 2 JREMENT Amplitude, Ti 28 sets: Vpp, Freq, Period, measurement Voltage differe 6 digits, range JTS(OPTION) VRMS, VCrest Freq, Mag, Mi Vripple, Irippl	z 5GSa/s iximum for all r age, Peak detec 256 waveforms we, Gating avz Vamp , Vavg , , Rise time , Fa ts (FRR, FRF, F ence between c e from 2Hz min factor, Frequenc ag rms, Phase, le	2.5GSa/s models ct, High resolut ; Peak detect: 2 ailable Vrms , Vhi , Vlo II time , Positivu FR, FFF, LRR, L ursors (CV) T nimum to the r.	5GSa/s tion, Single 2ns , Vmax , Vmin e width , Negati RF, LFR, LFF) ime difference l ated bandwidth factor, True pow	, Rise Preshoo ve width , Duty between cursor	t/ Overshoot , I cycle, Phase, a s (△T)	Fall Preshoot/C nd eight differe	vershoot, nt delay
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate ET Sample Rate Memory Depth Acquisition Mode CURSORS AND MEASU CURSORS AND MEASU CURSORS AND MEASU CURSORS Measurement Auto Counter POWER MEASUREMEN Power Quality Measurements Harmonics Ripple Measurements In-rush current	±3°at 100kH: 2.5CSa/s 100CSa/s ma 25k points Normal, Avera Average: 2 ~ 2 JREMENT Amplitude, Ti 28 sets: Vpp , Freq , Period , measurement Voltage differe 6 digits, range ITS(OPTION) VRMS, VCrest Freq, Mag, Mi Vripple ,Irippl First peak, see	z 5GSa/s iximum for all r age, Peak detec 256 waveforms we, Gating avz Vamp , Vavg , , Rise time , Fa ts (FRR, FRF, F ence between c e from 2Hz min factor, Frequenc ag rms, Phase, le	2.5GSa/s models ct, High resolut ; Peak detect: 2 ailable Vrms , Vhi , Vlo II time , Positivu FR, FFF, LRR, L ursors (CV) T nimum to the r.	5GSa/s tion, Single 2ns , Vmax , Vmin e width , Negati RF, LFR, LFF) ime difference l ated bandwidth factor, True pow	, Rise Preshoo ve width , Duty between cursor	t/ Overshoot , I cycle, Phase, a s (△T)	Fall Preshoot/C nd eight differe	vershoot, nt delay
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate ET Sample Rate Memory Depth Acquisition Mode CURSORS AND MEASU Cursors Automatic Measurement Cursors Measurement Auto Counter POWER MEASUREMEN Power Quality Measurements Harmonics Ripple Measurements In-rush current CONTROL PANEL FUN	±3°at 100kH: 2.5GSa/s 100GSa/s ma 25k points Normal, Avera Average: 2 ~ 2 JREMENT Amplitude, Ti 28 sets: Vpp, Freq, Period, measurement Voltage differe 6 digits, range ITS(OPTION) VRMS, VCrest Freq, Mag, M: Vripple, Irippl First peak, see CTION	z 5GSa/s iximum for all r age, Peak detee 256 waveforms waveforms Vamp , Vavg , , Rise time , Fa ts (FRR, FRF, F ence between c e from 2Hz min factor, Frequence ag rms, Phase, le cond peak	2.5GSa/s nodels ct, High resolut ; Peak detect: 2 ailable Vrms , Vhi , Vlc II time , Positive FR, FFF, LRR, L ursors (\triangle V) T nimum to the r. cy, IRMS, ICrest THD-F, THD-F	5GSa/s ion, Single 2ns , Vmax , Vmin e width , Negati RF, LFR, LFF) ime difference l ated bandwidth factor, True pow 2, RMS	, Rise Preshoo ve width , Duty petween cursor er, Apparent pov	t/ Overshoot , l cycle, Phase, a s (△T) ver, Reactive pov	Fall Preshoot/O nd eight differe ver, Power facto	vershoot, ent delay r, Phase angle.
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate ET Sample Rate Memory Depth Acquisition Mode CURSORS AND MEASU Cursors Automatic Measurement Cursors Measurement Auto Counter POWER MEASUREMEN Power Quality Measurements Harmonics Ripple Measurements In-rush current CONTROL PANEL FUN Autoset	±3°at 100kH: 2.5CSa/s 100CSa/s ma 25k points Normal, Aver. Average: 2 ~ 2 JREMENT Amplitude, Ti 28 sets: Vpp, Freq, Period, measurement Voltage differe 6 digits, range JTS(OPTION) VRMS, VCrest Freq, Mag, Ma Vripple, Jrippl First peak, see CTION Single-button	z 5GSa/s iximum for all r age, Peak detec 256 waveforms "me, Gating ava Vamp , Vavg , , Rise time , Fa ts (FRR, FRF, F ence between c e from 2Hz min factor, Frequence ag rms, Phase, le cond peak , automatic set	2.5GSa/s nodels ct, High resolut ; Peak detect: 2 ailable Vrms, Vhi , Vko II time , Positive FR, FFF, LRR, L cursors (\triangle V) T nimum to the r cy, IRMS, ICrest THD-F, THD-F	5GSa/s tion, Single 2ns , Vmax , Vmin e width , Negati RF, LFR, LFF) ime difference l ated bandwidth factor, True pow R, RMS els for vertical,	, Rise Preshoo ve width , Duty between cursor er, Apparent pov horizontal and	t/ Overshoot , l cycle, Phase, a s (△T) ver, Reactive pow trigger system	Fall Preshoot/C nd eight differe wer, Power facto s, with undo au	vershoot, ent delay r, Phase angle. toset
X-Axis Input/Y-Axis Input Phase Shift SIGNAL ACQUISITION Real Time Sample Rate ET Sample Rate Memory Depth Acquisition Mode CURSORS AND MEASU Cursors Automatic Measurement Cursors Measurement Auto Counter POWER MEASUREMEN Power Quality Measurements Harmonics Ripple Measurements In-rush current CONTROL PANEL FUN	±3°at 100kH: 2.5CSa/s 100CSa/s ma 25k points Normal, Aver. Average: 2 ~ 2 JREMENT Amplitude, Ti 28 sets: Vpp, Freq, Period, measurement Voltage differe 6 digits, range JTS(OPTION) VRMS, VCrest Freq, Mag, Ma Vripple, Jrippl First peak, see CTION Single-button	z 5GSa/s iximum for all r age, Peak detec 256 waveforms me, Gating avz Vamp , Vavg , , Rise time , Fa ts (FRR, FRF, F ence between c e from 2Hz min factor, Frequenc ag rms, Phase, le cond peak , automatic set cally adjusts the ti	2.5GSa/s nodels ct, High resolut ; Peak detect: 2 ailable Vrms, Vhi , Vko II time , Positive FR, FFF, LRR, L cursors (\triangle V) T nimum to the r cy, IRMS, ICrest THD-F, THD-F	5GSa/s ion, Single 2ns , Vmax , Vmin e width , Negati RF, LFR, LFF) ime difference l ated bandwidth factor, True pow 2, RMS	, Rise Preshoo ve width , Duty between cursor er, Apparent pov horizontal and	t/ Overshoot , l cycle, Phase, a s (△T) ver, Reactive pow trigger system	Fall Preshoot/C nd eight differe wer, Power facto s, with undo au	vershoot, ent delay r, Phase angle. toset

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	GD	S-3152	GDS-3154	GDS-3252	GDS-3	254 GE	DS-3352	GDS-3354	GDS-3502	GDS-35
DISPLAY SYSTE	Μ									
TFT LCD Type				olay(LED Back-l	light)					
Waveform Update) wfms/s								
Display Resolution			al x 600 vertical uivalent time s	pixels (SVGA)						
Waveform Displa				stence, Infinite	persister	ice				
Display Graticule		0 divisio		,	F					
Display Brightne	ss Adju	stable								
NTERFACE										
RS-232C) male co								
USB Port				ost port ;1 set	USB high-	speed 2.0	device por	t		
Ethernet Port SVGA Video Port			tor, 10/100Mbp	os onitor output fo	or display	on SVGA r	nonitors			
GPIB			Adapter (Optio		n uispiay	UII SVGAT	nonntors			
Go/NoGo BNC			A TTL open col	lector output						
Internal Flash Di										
Kensington Style Line Output				nects to standa IoGo audio alar		gton-style	lock			
OPERATING EN										
Temperature			lative Humidity	′≤80% at 40 [°] C o	or below · ·	< 45% at 4	1° C~50° C			
POWER SOURC	I	50 0, 10				_ 10/0 40 1				
Line Voltage Ran		00V ~ 24	0V. 50Hz ~ 60I	Hz, auto selecti	on					
MISCELLANEOU	0			,						
Multi-Language	Menu Avail	able								
On-Line Help	Avail	able								
Time Clock	Time	e and dat	e, provide the	date/time for s	aved data					
DIMENSIONS &	& WEIGHT									
	400(W) X 200)(H) X 130(D)r	nm, Approx. 4 l	kg					
* Three-year w	arranty, excl	uding p	robes & LCD	display pane	el.		Sp	ecifications su	bject to change	without no
ORDERING			N	. , .						
GDS-3354 3 GDS-3252 2 GDS-3254 2 GDS-3152 1	50MHz, 4-Cha 50MHz, 2-Cha 50MHz, 4-Cha 50MHz, 2-Cha 50MHz, 4-Cha D x 1 ,Power c	annel, Vi annel, Vi annel, Vi annel, Vi annel, Vi	sual Persistend sual Persistend sual Persistend sual Persistend sual Persistend sual Persistend	te DSO te DSO te DSO te DSO te DSO te DSO	annel)					
GTP-251R : 2501	MHz 10:1 pass	ive probe	for GDS-3252/	3254 (one per ch	nannel)					
GTP-351R : 350		ive prope	101 005-3502/	JJU4 JONE DEr C	narmel)					
GTP-351R : 3501 GTP-501R : 5001	initiz 10.1 pass		,	() () () () () () () () () ()						
GTP-351R : 3500 GTP-501R : 5000 Option			, Power quality/Ha	X I	n-rush cur	rent measu	rements			
GTP-351R : 3501 GTP-501R : 5001 Option DS3-PWR P	ower analysis s	oftware: P		rmonic/Ripple/I (only 4 channel m						
GTP-351R : 3501 GTP-501R : 5001 Option DS3-PWR P	ower analysis s erial Bus analysi	oftware: P		rmonic/Ripple/I						
GTP-351R : 3501 GTP-501R : 5001 Option DS3-PWR P DS3-SBD S Optional Acces GUG-001 G	ower analysis s erial Bus analysi ssories iPIB to USB ada	oftware: F is software apter	e ² I C/SPI/UART	rmonic/Ripple/I (only 4 channel m	nodels supp GSC-008	oort SPI fun Soft Carryir	ction) ng Case			
GTP-351R : 3501 GTP-501R : 5001 Option DS3-PWR P DS3-SBD S Optional Accer GUG-001 G GTP-033A 3	ower analysis s erial Bus analysi ssories SPIB to USB ada 5MHz 1:1 Pass	oftware: F is software apter sive probe	e?I C/SPI/UART	rmonic/Ripple/I (only 4 channel m C	nodels supp SSC-008 STL-110	oort SPI fun Soft Carryir Test lead, B	ction) ng Case NC to BNC			
GTP-351R : 3501 GTP-501R : 5001 Option DS3-PWR P DS3-SBD S0 Optional Accer GUG-001 G GTP-033A 3 GTP-352R 3	ower analysis s erial Bus analysi ssories :PIB to USB ada 5MHz 1:1 Pass 50MHz 20:1 Pa	oftware: F is software apter sive probe assive pro	e ² I C/SPI/UART	rmonic/Ripple/I (only 4 channel m C	nodels supp GSC-008	Soft Carryir Test lead, B RS-232C ca	ction) ng Case NC to BNC ble, 9-pin fer	nale to		
GTP-351R : 3501 GTP-501R : 5001 Option DS3-PWR P DS3-SBD S Optional Access G GTP-033A 3 GTP-352R 3 GDP-025 2	ower analysis s erial Bus analysi ssories SPIB to USB ada 5MHz 1:1 Pass	oftware: F is software apter sive probe assive pro age differe	21 C/SPI/UART	rmonic/Ripple/I (only 4 channel m C C C	SSC-008 STL-110 STL-232	Soft Carryir Test lead, B RS-232C ca 9-pin femal computer	ction) ng Case NC to BNC ble, 9-pin fer e, Null mode	nale to em for		
GTP-351R : 3501 GTP-501R : 5001 DS3-PWR P DS3-SBD 50 Optional Acces GUG-001 G GTP-033A 3 GTP-352R 3 GDP-025 22 GDP-050 50 GDP-100 10	ower analysis s erial Bus analysi ssories SMHz 1:1 Pass 50MHz 20:1 Pa 5MHz High volt 0MHz High volt 00MHz High volt	oftware: F is software apter ive probe assive pro age differe age differe tage differe	2 [?] I C/SPI/UART be ential probe ential probe	rmonic/Ripple/I (only 4 channel m C C C	nodels supp SSC-008 STL-110	Soft Carryir Test lead, B RS-232C ca 9-pin femal computer USB 2.0 cal	ction) ng Case NC to BNC ble, 9-pin fer	nale to em for		
GTP-351R : 3501 GTP-501R : 5001 DS3-PWR P DS3-SBD S Optional Accer GUG-001 G GTP-033A 3 GTP-352R 3 GDP-025 22 GDP-050 50 GDP-100 10 GCP-005 1	ower analysis s erial Bus analysi ssories PIB to USB ada 5MHz 1:1 Pass 50MHz 20:1 Pa 5MHz High volt 0MHz High volt 0MHz High volt kHz/5A Curren	oftware: F is software ive probe assive pro age differe tage differe tage differe t probe	2 [?] I C/SPI/UART be ential probe ential probe ential probe	rmonic/Ripple/I (only 4 channel m C C C	SSC-008 STL-110 STL-232	Soft Carryir Test lead, B RS-232C ca 9-pin femal computer USB 2.0 cal 1800mm	ction) ng Case NC to BNC ble, 9-pin fer e, Null mode ble, A-B type	nale to em for		
GTP-351R : 3501 GTP-501R : 5001 Option DS3-PWR P DS3-SBD S0 Optional Access GUG-001 G GUP-033A 33 GTP-352R 3 GDP-025 22 GDP-050 56 GDP-100 10 GCP-005 11 GCP-020 10 11 11	ower analysis s erial Bus analysi ssories 5MHz 1:1 Pass 50MHz 20:1 Pa 5MHz High volt 0MHz High volt 00MHz High vol kHz/5A Curren 0kHz/200A Cur	oftware: F is software ive probe assive pro age differe age differe tage differe t probe rrent prob	e?1 C/SPI/UART be ential probe ential probe ential probe ential probe	rmonic/Ripple/I (only 4 channel m C C C C	SSC-008 GTL-110 GTL-232 GTL-246	Soft Carryir Test lead, B RS-232C ca 9-pin femal computer USB 2.0 cal 1800mm Rack Adap Oscilloscoj	ction) ng Case NC to BNC o ble, 9-pin fer e, Null mode ble, A-B type ter Panel pe Educatio	nale to em for cable 4P,		
GTP-351R : 3501 GTP-501R : 5001 GTP-501R : 5001 DS3-PWR P DS3-SBD S Optional Access GUF-001 G GTP-033A 3 GDP-025 22 GDP-050 50 GDP-100 10 GCP-020 11 GCP-100 10	ower analysis s erial Bus analysi ssories PIB to USB ada 5MHz 1:1 Pass 50MHz 20:1 Pa 5MHz High volt 0MHz High volt 0MHz High volt kHz/5A Curren	oftware: F is software apter ive probe assive pro- age differe tage differe	2 ² 1 C/SPI/UART be ential probe ential probe ential probe ential probe e be	rmonic/Ripple/I (only 4 channel m C C C C C C C C C C	CSC-008 CTL-110 CTL-232 CTL-246 CRA-411 CDB-03	Soft Carryir Test lead, B RS-232C ca 9-pin femal computer USB 2.0 cal 1800mm Rack Adap Oscilloscoj Training Ki	ction) ng Case NC to BNC o ble, 9-pin fer e, Null mode ble, A-B type ter Panel pe Educatio t	nale to em for cable 4P,		
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GDS-3000 Series

